Notice of References Cited Application/Control No. 10/733,990 Examiner Khawar Iqbal Applicant(s)/Patent Under Reexamination HAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0120287 A1	06-2004	Lott et al.	370/332
*	В	US-2005/0169301 A1	08-2005	Jain et al.	370/464
*	С	US-2002/0196755 A1	12-2002	Hidaka et al.	370/335
*	D	US-6,822,969 B2	11-2004	Love et al.	370/444
*	Ε	US-6,983,153 B2	01-2006	Jain et al.	455/453
	F	US-			
ļ.,	G	US-			
	Н	US-	1		
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.